

N Channel MOSFET



Lead Free Package and Finish

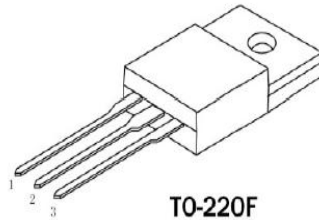
Applications:

- Adapter & Charger
- SMPS Standby Power
- AC-DC Switching Power Supply
- LED driving power

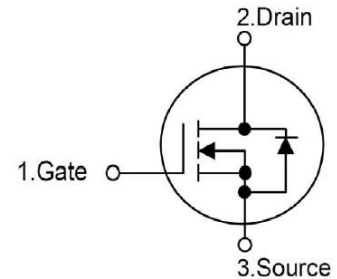
Features:

- Low On Resistance
- Low Gate Charge
- Peak Current vs Pulse Width Curve
- RoHS Compliant

I_D	$R_{DS(ON)}(Typ.)$	V_{DSS}
7A	1.1Ω	650V



TO-220F



Not to Scale

Ordering Information

Part Number	Package	Marking
RS7N65F	TO-220F	RS7N65F

Absolute Maximum Ratings $T_c=25^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	RS7N65F	Units
V_{DSS}	Drain-to-Source Voltage (Note*1)	650	V
I_D	Continuous Drain Current	7.0	A
$I_{D@ 100^{\circ}\text{C}}$	Continuous Drain Current	4.5	
I_{DM}	Pulsed Drain Current (Note*2)	28.0	
PD	Power Dissipation	97	W
VGS	Gate-to-Source Voltage	±30	V
EAS	Single Pulse Avalanche Energy L=10mH VDD=50V RG=25Ω Starting $T_J=25^{\circ}\text{C}$	101	mJ
TL TPKG	Maximum Temperature for Soldering	300 260	$^{\circ}\text{C}$
	Leads at 0.063in(1.6mm)from Case for 10 seconds		
	Package Body for 10 seconds		
T_J and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

*Drain Current Limited by Maximum Junction Temperature

Caution:Stresses greater than those listed in the“Absolute Maximum Ratings”Table may cause permanent damage to the device.

Thermal Resistance

Symbol	Parameter	RS7N65F	Units	Test Conditions
$R_{\theta JC}$	Junction-to-Case	1.29	$^{\circ}\text{C}/\text{W}$	Drain lead soldered to water cooled heatsink,PD adjusted for a peak junction temperature of +150 $^{\circ}\text{C}$.
$R_{\theta JA}$	Junction-to-Ambient	60		1 cubic foot chamber,free air.

OFF Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
BVDSS	Drain-to-source Breakdown Voltage	650	--	--	V	V _{GS} =0V, I _D =250μA
IDSS	Drain-to-Source Leakage Current	--	--	1.0	μA	V _{DS} =650V, V _{GS} =0V
IGSS	Gate-to-Source Forward Leakage	--	--	100	nA	V _{GS} =+30V V _{DS} =0V
	Gate-to-Source Reverse Leakage	--	--	-100		V _{GS} =-30V V _{DS} =0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
RDS(on)	Static Drain-to-Source On-Resistance (Note*3)	--	1.1	1.4	Ω	V _{GS} =10V, I _D =3.5A
VGS(TH)	Gate Threshold Voltage	3.0	--	4.0	V	V _{GS} =V _{DS} , I _D =250μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
t _d (ON)	Turn-on Delay Time	--	15	--	nS	V _{DS} =325V I _D =7A R _G =25Ω (Note:3,4)
t _{rise}	Rise Time	--	18	--		
t _d (OFF)	Turn-OFF Delay Time	--	80	--		
t _{fall}	Fall Time	--	35	--		

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
C _{iss}	Input Capacitance	--	890	--	pF	V _{GS} =0V V _{DS} =25V f=1.0MHz
C _{oss}	Output Capacitance	--	110	--		
C _{rss}	Reverse Transfer Capacitance	--	14	--		
Q _g	Total Gate Charge	--	22	--	nC	V _{DS} =520V I _D =7A V _{GS} =10V (Note:3,4)
Q _{gs}	Gate-to-Source Charge	--	4.3	--		
Q _{gd}	Gate-to-Drain("Miller") Charge	--	13	--		

Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I _S	Continuous Source Current	--	--	7.0	A	Integral pn-diode in MOSFET
I _{SM}	Maximum Pulsed Current	--	--	28.0	A	
V _{SD}	Diode Forward Voltage	--	--	1.4	V	I _S =7A, V _{GS} =0V
t _{rr}	Reverse Recovery Time	--	300	--	nS	V _{GS} =0V
Q _{rr}	Reverse Recovery Charge	--	4.1	--	μC	I _S =7A, di/dt=100A/μs

Notes:

- *1. T_J=±25°C to +150°C.
- *2. Repetitive rating; pulse width limited by maximum junction temperature.
- *3. Pulse width ≤ 300μs; duty cycle ≤ 1%.

Typical Feature curve

T_J = 25°C, unless otherwise noted

Figure 1. Output Characteristics (T_J = 25°C)

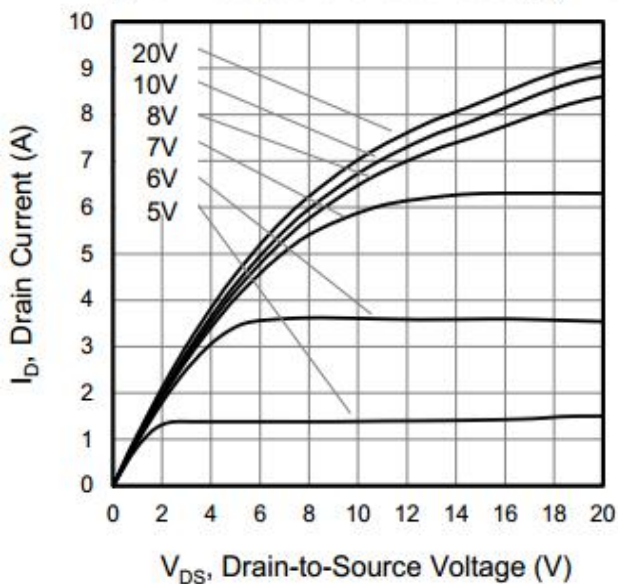


Figure 2. Body Diode Forward Voltage

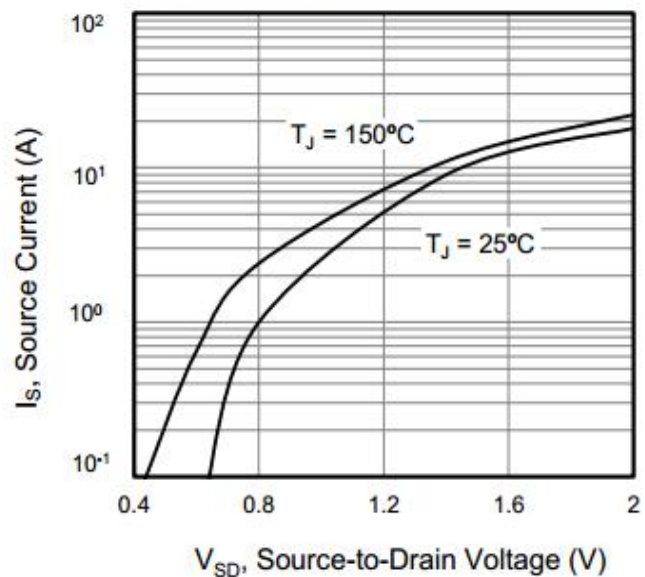


Figure 3. Drain Current vs. Temperature

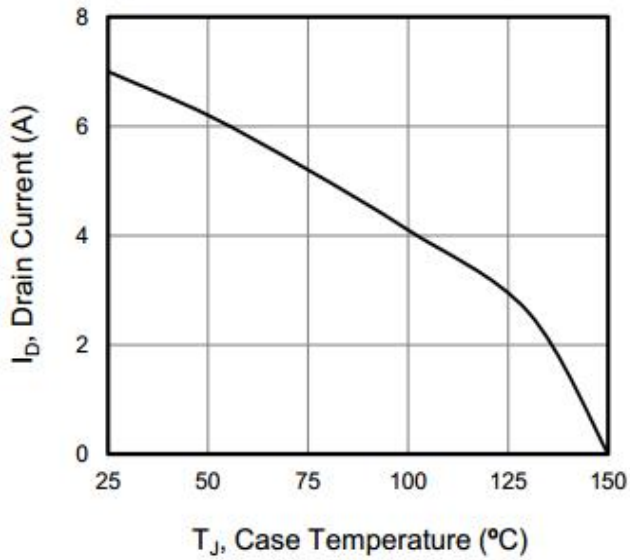


Figure 4. BV_{DSS} Variation vs. Temperature

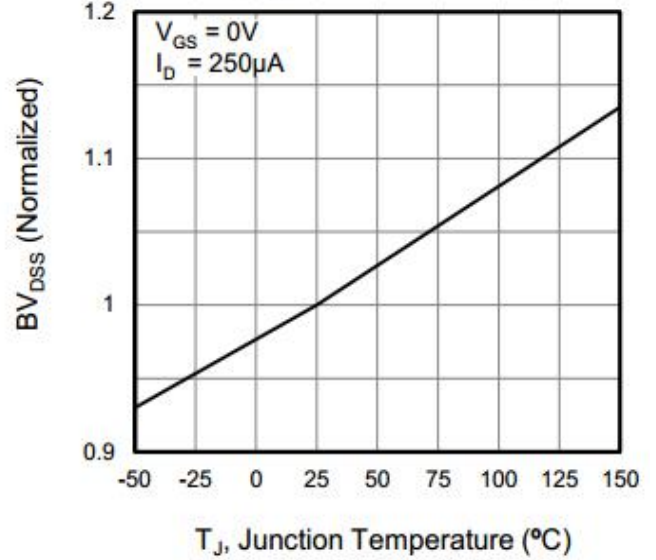


Figure 5. Transfer Characteristics

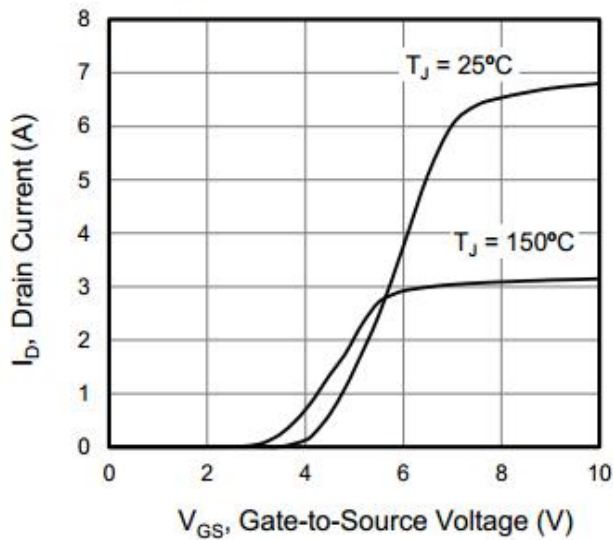


Figure 6. On-Resistance vs. Temperature

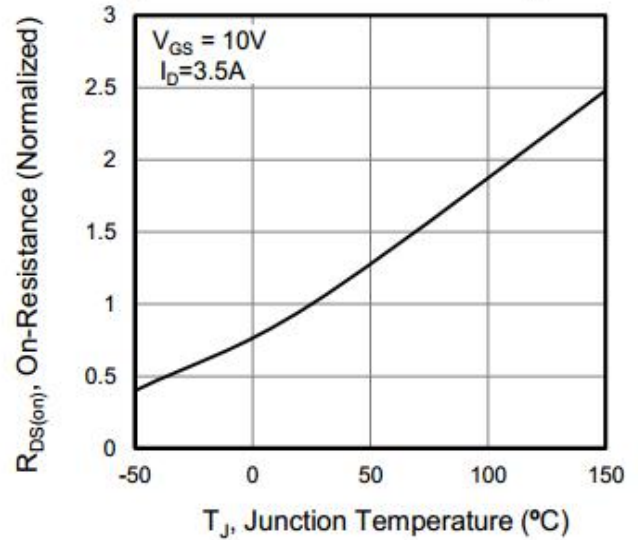


Figure 7. Capacitance

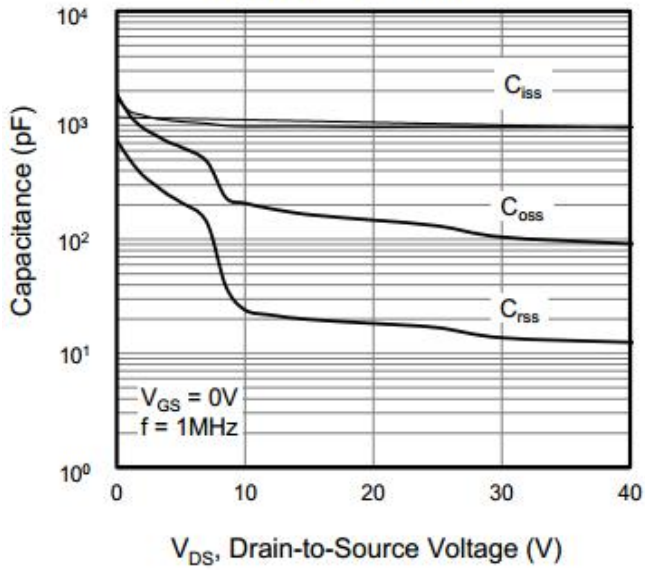


Figure 8. Gate Charge

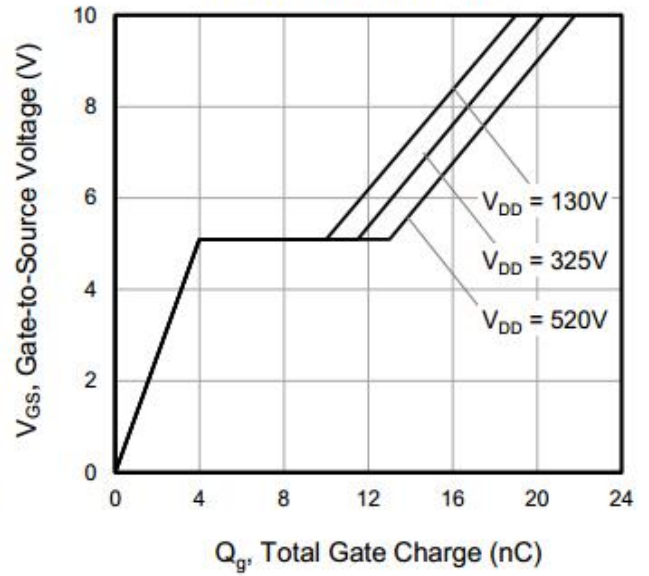
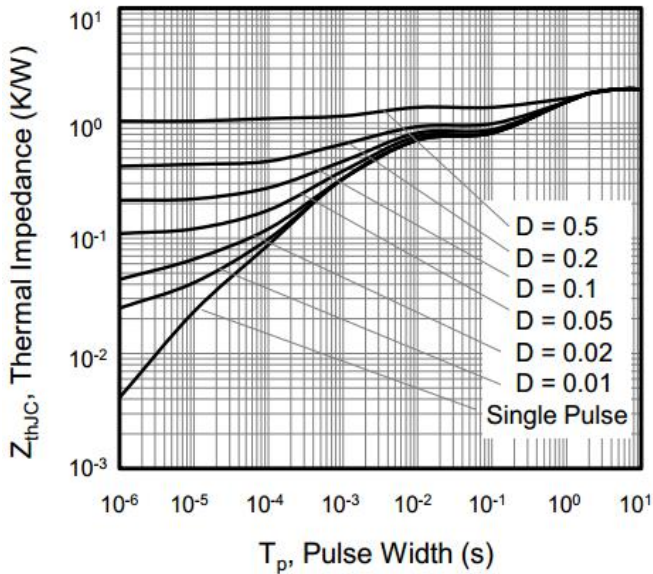


Figure 9. Transient Thermal Impedance

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Test Circuits and Waveforms

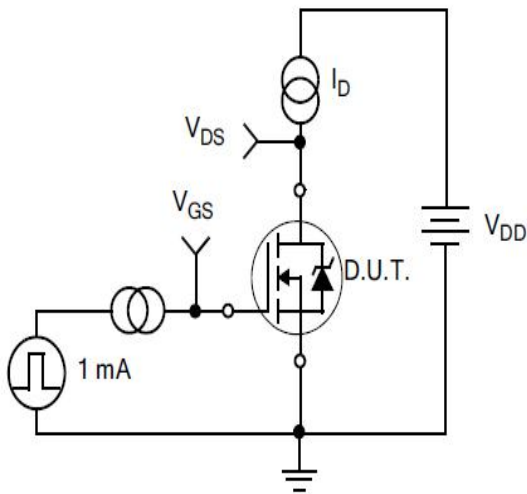


Figure10.
Gate Charge Test Circuit

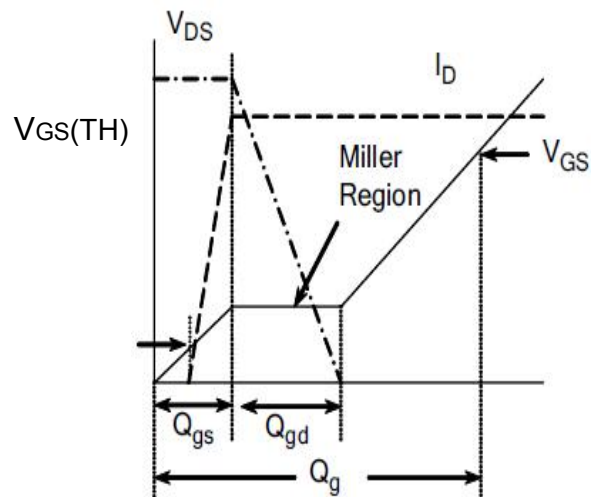


Figure11.
Gate Charge Waveform

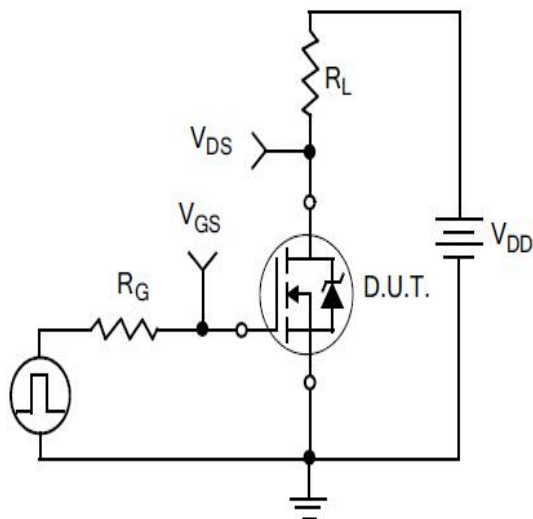


Figure12.
Resistive Switching Test Circuit

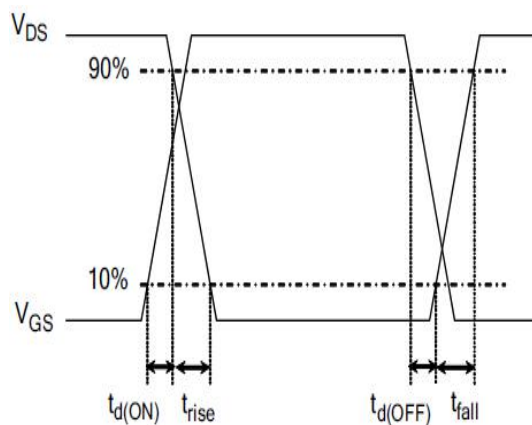


Figure13.
Resistive Switching Waveforms

Test Circuits and Waveforms

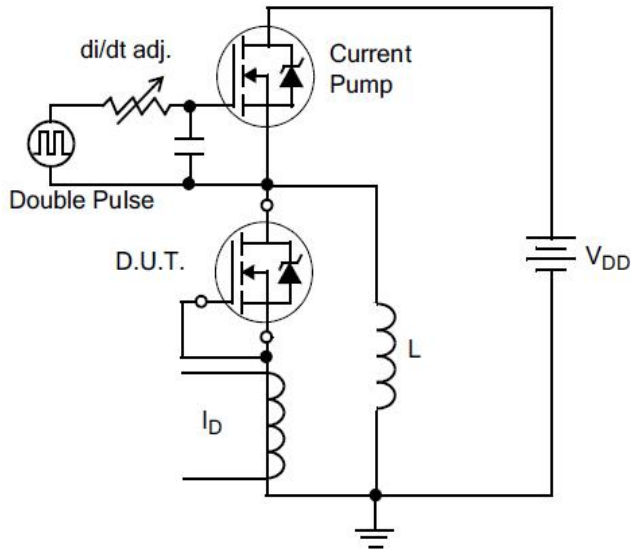


Figure14.Diode Reverse Recovery Test Circuit

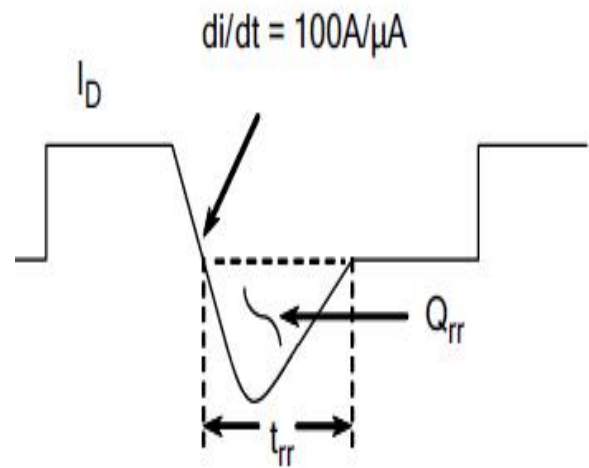


Figure15.Diode Reverse Recovery Waveform

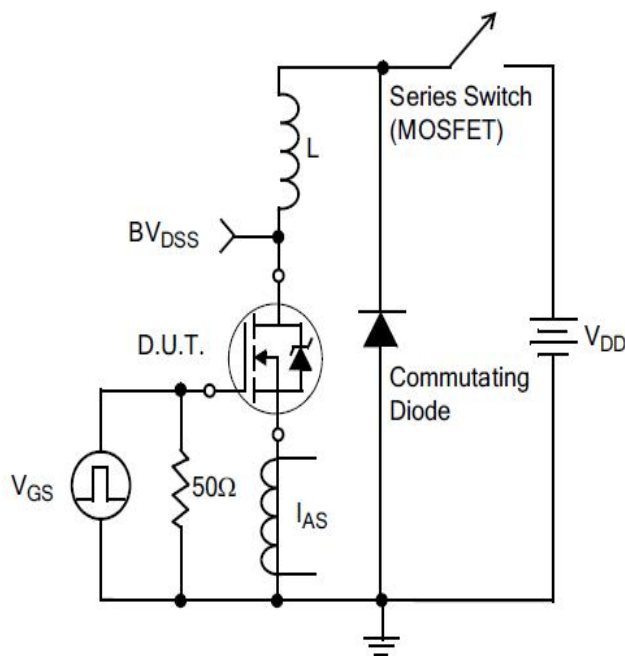
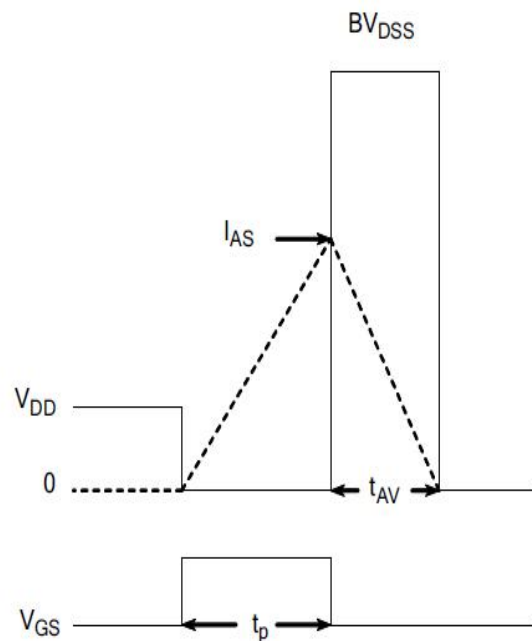


Figure16.Unclamped Inductive Switching Test Circuit



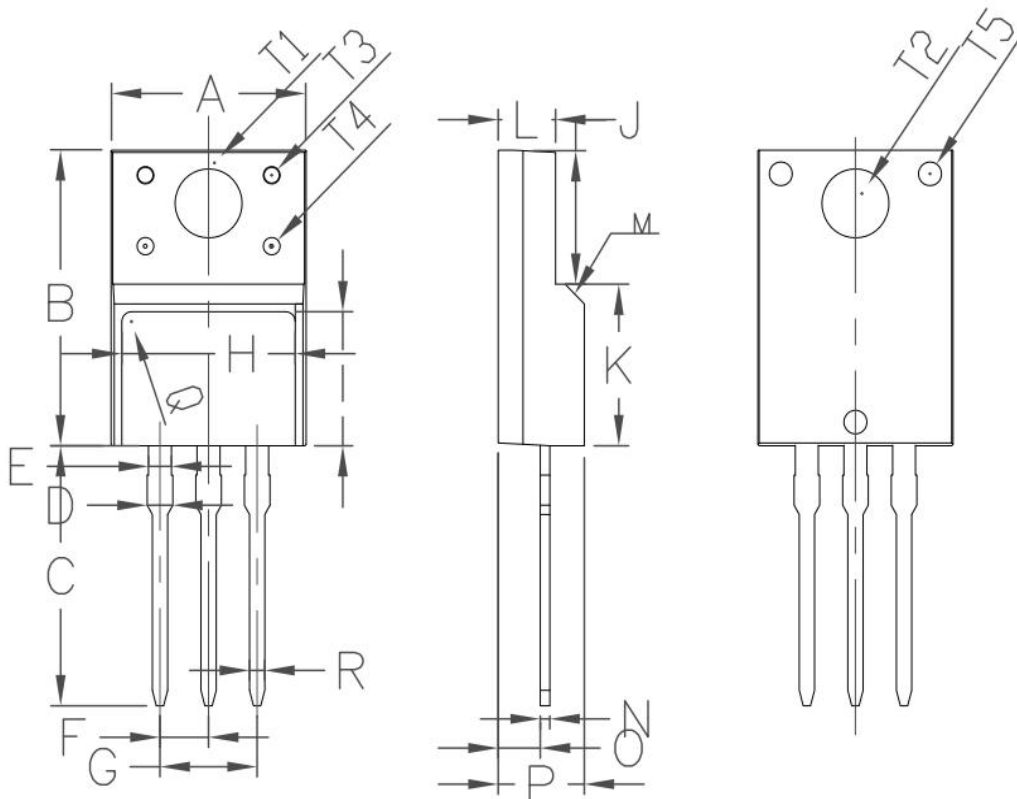
$$E_{AS} = \frac{I_{AS}^2 L}{2}$$

Figure17.Unclamped Inductive Switching Waveforms

Package outline drawing

Unit: mm

TO-220F



Symbol	Min	Non	Max
A	9.96	10.16	10.36
B	15.67	15.87	16.07
C	13.14	13.34	13.54
D	1.20	1.30	1.40
E		1.20	
F		2.54	
G		5.08	
H	7.60	7.80	8.00
I	7.10	7.30	7.50
J	6.48	6.68	6.88
K	8.99	9.19	9.39
L	2.34	2.54	2.74
M		45°	
N	0.49	0.50	0.52
O	2.15	2.35	2.55
P	4.50	4.70	4.90
Q		0.50	
S	4°	4.5°	5°
T1		3.45	
T2		3.18	
T3		1.50	
T4		1.20	
T5		1.50	
R	0.77	0.8	0.83

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